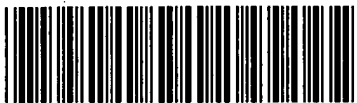


**Search Notes**

Application/Control No.

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Examiner

VAN T. PHAM

Applicant(s)/Patent under  
Reexamination

LEE, GAB JAE

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
369	47.51	5/1/2007	VP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
pgpub	text search	1/4/2008	VP
Interference search (see search history printout).			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369, 385 (text search only see search history printout).	1/4/2008	VP